

<b>Notice of References Cited</b>	Application/Control No. 10/763,395	Applicant(s)/Patent Under Reexamination KWON ET AL.	
	Examiner CHRISTINE M. BEHNCKE	Art Unit 3661	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0114960	06-2003	Takenaka et al.	700/245
	B	US-			
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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